

# **MOSFET** – Power, Single, N-Channel, TOLL

# 60 V, 0.9 mΩ, 422 A

# NTBLS001N06C

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage	€		$V_{GS}$	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	422	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	State	$T_C = 25^{\circ}C$	P <sub>D</sub>	284	W
Continuous Drain Current $R_{\theta,JA}$ (Notes 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	51	Α
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.2	W
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	236	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 39 A)			E <sub>AS</sub>	760	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

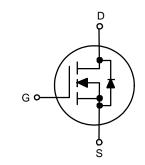
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.53	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

<sup>1.</sup> Surface–mounted on FR4 board using a 1 in<sup>2</sup> pad size, 2 oz. Cu pad.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
60 V	0.9 mΩ @ 10 V	422 A	
60 V	1.4 mΩ @ 6 V		





MO-299A TOLL CASE 100CU

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBLS001N06C	MO-299A (Pb-Free)	2000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

Table 1. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Cond	litions	Min	Тур	Max	Units
OFF CHARACTERISTICS		•		•			
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 250 μA, \	/ <sub>GS</sub> = 0 V	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	I <sub>D</sub> = 562 μA, re	ef to 25°C		26		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V,	T <sub>J</sub> = 25°C			10	μΑ
		$V_{GS} = 0 \text{ V}$	T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>O</sub>	<sub>GS</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 3)	•			•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 562 μΑ	2.0	2.8	4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(th)</sub> /T <sub>J</sub>	I <sub>D</sub> = 562 μA, re	ef to 25°C		9.9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I	<sub>D</sub> = 80 A		0.75	0.9	mΩ
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 6 V, I <sub>E</sub>	<sub>O</sub> = 56 A		1.09	1.4	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 5 V, I <sub>E</sub>	O = 80 A		290		S
Gate-Resistance	$R_{G}$	T <sub>A</sub> = 25	5°C		0.6		Ω
CHARGES & CAPACTIANCES	1			·			1
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 10 \text{ kHz}$			11575		pF
Output Capacitance	C <sub>oss</sub>				5973		pF
Reverse Transfer Capacitance	C <sub>rss</sub>				76		pF
Total Gate Charge	Q <sub>G(tot)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 30 \text{ V},$ $I_{D} = 80 \text{ A}$ $V_{GS} = 6 \text{ V}, V_{DS} = 30 \text{ V},$ $I_{D} = 80 \text{ A}$			143		nC
Threshold Gate Charge	Q <sub>G(th)</sub>				31		nC
Gate-to-Source Charge	Q <sub>gs</sub>				54		nC
Gate-to-Drain Charge	Q <sub>gd</sub>				13		nC
Total Gate Charge	Q <sub>G(tot)</sub>				52		nC
SWITCHING CHARACTERISTICS, V <sub>GS</sub> = 10	<b>0 V</b> (Note 3)						1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = 10 \text{ V, } V_{I}$ $I_{D} = 80 \text{ A, R}$	<sub>DS</sub> = 30 V,		34		ns
Rise Time	t <sub>r</sub>	I <sub>D</sub> = 80 A, R	$_{\rm G}$ = 6 $\Omega$		53		ns
Turn-Off Delay Time	t <sub>d(off)</sub>				119		ns
Fall Time	t <sub>f</sub>				91		ns
DRAIN-SOURCE DIODE CHARACTERISTI	cs			•			
Forward Diode Voltage	$V_{SD}$	I <sub>S</sub> = 80 A, V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C		0.79	1.2	V
	,	I <sub>S</sub> = 80 A, V <sub>GS</sub> = 0 V	T <sub>J</sub> = 125°C	1	0.66		V
Reverse Recovery Time	t <sub>rr</sub>	$V_{GS} = 0 \text{ V, dI}_{S}/d_{t}$	= 100 A/μs,	1	120		ns
Charge Time	t <sub>a</sub>	I <sub>S</sub> = 56 A			60		ns
Discharge Time	t <sub>b</sub>				60		ns
Reverse Recovery Charge	Q <sub>rr</sub>	1			322		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

#### **TYPICAL CHARACTERISTICS**

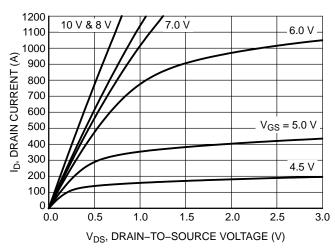


Figure 1. On-Region Characteristics

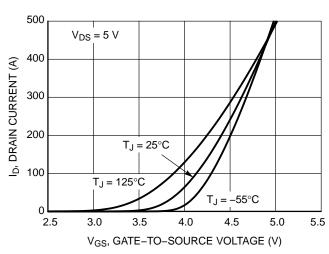


Figure 2. Transfer Characteristics

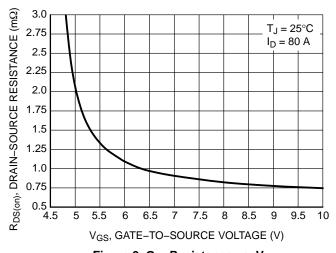


Figure 3. On–Resistance vs.  $V_{GS}$ 

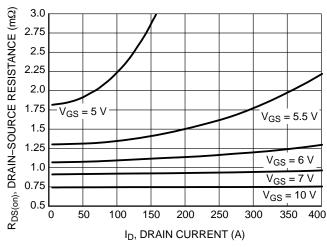


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

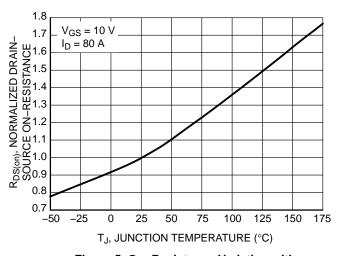


Figure 5. On–Resistance Variation with Temperature

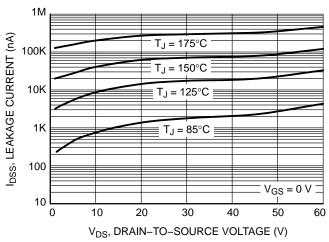


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

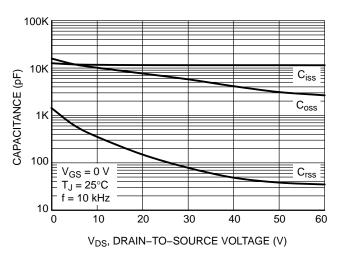


Figure 7. Capacitance Variation

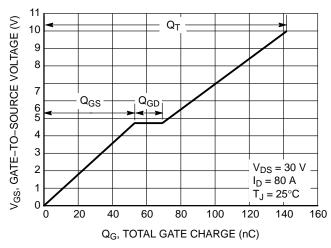


Figure 8. Gate-to-Source Voltage vs. Total Gate Charge

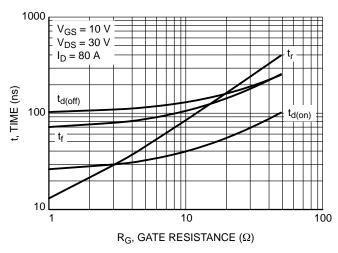


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

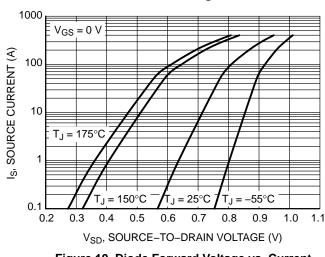


Figure 10. Diode Forward Voltage vs. Current

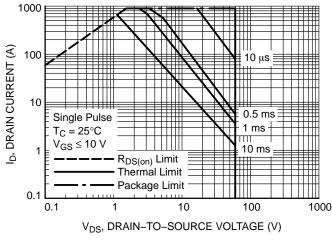


Figure 11. Maximum Rated Forward Biased Safe Operating Area

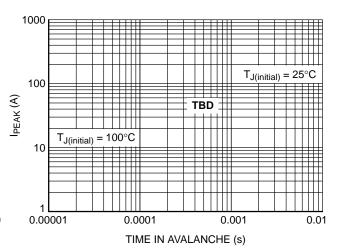


Figure 12. Peak Power

#### **TYPICAL CHARACTERISTICS**

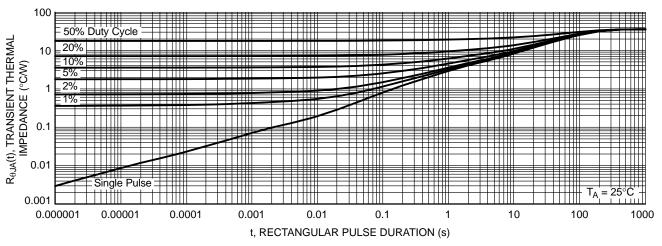


Figure 13. Thermal Response (Junction-to-Ambient)

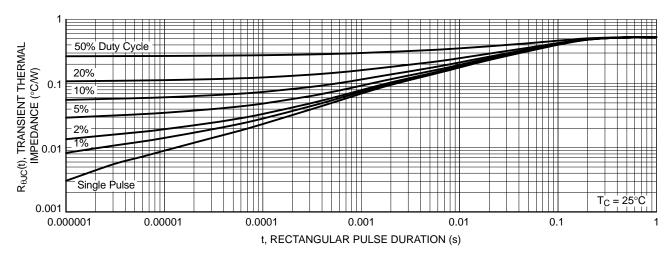
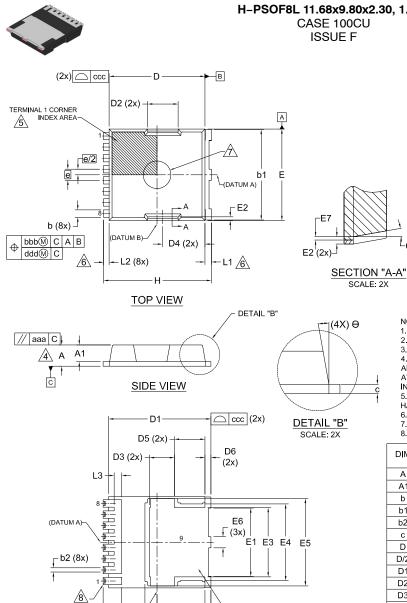


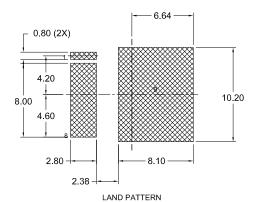
Figure 14. Thermal Response





## H-PSOF8L 11.68x9.80x2.30, 1.20P CASE 100CU

**DATE 30 JUL 2024** 



RECOMMENDATION \*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### NOTES:

HATCHED AREA

- 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE B.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- 3. "e" REPRESENTS THE TERMINAL PITCH.
- 4. THIS DIMENSION INCLUDES ENCAPSULATION THICKNESS "A1", AND PACKAGE BODY THICKNESS, BUT DOES NOT INCLUDE ATTACHED FEATURES, e.g., EXTERNAL OR CHIP CAPACITORS. AN INTEGRAL HEATSLUG IS NOT CONSIDERED AS ATTACHED FEATURE. 5. A VISUAL INDEX FEATURE MUST BE LOCATED WITHIN THE
- 6. DIMENSIONS b1,L1,L2 APPLY TO PLATED TERMINALS.
- 7. THE LOCATION AND SIZE OF EJECTOR MARKS ARE OPTIONAL.
  8. THE LOCATION AND NUMBER OF FUSED LEADS ARE OPTIONAL.

DIM	MIL	LIMETE	RS
	MIN.	NOM.	MAX.
Α	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b2	0.35	0.45	0.55
С	0.40	0.50	0.60
D	10.28	10.38	10.48
D/2	5.09	5.19	5.29
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D3	2.60	2.70	2.80
D4	4.45	4.55	4.65
D5	3.20	3.30	3.40
D6	0.55	0.65	0.75
E	9.80	9.90	10.00
E1	7.30	7.40	7.50
E2	0.30	0.40	0.50
E3	7.40	7.50	7.60
E4	8.20	8.30	8.40

DIM	MILLIMETERS			
	MIN.	NOM.	MAX.	
E5	9.36	9.46	9.56	
E6	1.10	1.20	1.30	
E7	0.15	0.18	0.21	
е		1.20 BSC	;	
e/2	(	0.60 BSC	;	
Н	11.58	11.68	11.78	
H/2	5.74	5.84	5.94	
H1		7.15 BSC	;	
L	1.90	2.00	2.10	
L1	0.60	0.70	0.80	
L2	0.50	0.60	0.70	
L3	0.70	0.80	0.90	
θ	10° REF			
Θ1	10° REF			
aaa	0.20			
bbb	0.25			
ccc	0.20			
ddd	0.20			
eee	0.10			

## **GENERIC MARKING DIAGRAM\***

HEAT SLUG TERMINAL

Α = Assembly Location

**BOTTOM VIEW** 

D/2

= Year

L (8x)

(DATUM B)

WW = Work Week

= Assembly Lot Code XXXX = Specific Device Code

AYWWZZ XXXXXXX XXXXXXX

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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